

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/995,826	CHIBA ET AL.	
Examiner	Art Unit	
Thuy V. Tran	2821	

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Class	Subclass	Date	Examiner		
343	702	3/6/2005	т.т.		
-	767	3/6/2005	-		
-	846-850	3/6/2005	-		
-	900-901	3/6/2005	-		
•	906	3/6/2005	-		
455	73	3/6/2005	-		
•	550.1	3/6/2005	-		
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INTERFERENCE SEARCHED		
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